

Notice of References Cited

Application/Control No.

10/596,058

Applicant(s)/Patent Under

Reexamination

BUECHER ET AL.

Examiner

DAVID TUROCY

Art Unit

1792

Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,440,582	08-2002	McDevitt et al.	428/653
*	B US-6,068,890	05-2000	Kaumle et al.	427/534
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N EP 483810 A2	05-1992	European Patent	KONISHI et al.	
O	JP 02015154 A	01-1990	Japan	YONESAKA et al.	
P	JP 05261414 A	10-1993	Japan	TAKATOU et al.	
Q	KR 2001018653 A	03-2001	Korea, Republic	JIN Y G et al.	
R	WO 8401909 A1	05-1984	World Intellect	PANUSH, SOL	
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	
V	
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.